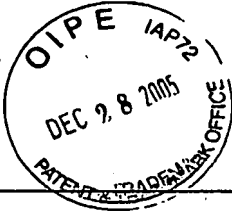


37 CFR 1.501 INFORMATION DISCLOSURE STATEMENT IN A PATENT (use several sheets if necessary)					Docket No. 09792909-5828		Serial No. 10/790,986	
					Applicants: Takeo Eguchi			
					Filing Date March 2, 2004		Group Art Unit <del>2124</del> 2193	
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Application Number		10790986
Filing Date		2004-03-02
First Named Inventor	Eguchi, T.	
Art Unit	2124 →	2193
Examiner Name	Not yet assigned →	Chat C. Do
Attorney Docket Number		09792909-5828

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/CD/	1	4272648	B	1981-06-09	Agrawal, B. P. et al.	
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/CD/	1	EP0387849	EP	A2	1990-09-19	Matsushita Electric Industrial Co., Ltd.		<input type="checkbox"/>

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Attorney Docket Number	09792909-5828

/CD/	2	JP61150034	JP	A	1986-07-08	Fujitsu Ltd.	<input type="checkbox"/>
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/CD/	1	NAOKI MIKAMI ET AL., "Roundoff-Error Reduction for Evaluation of a Function by Polynomial Approximation With Error Feedback in Fixed-Point Arithmetic"; IEEE Transactions On Signal Processing, Volume 41, No. 5; May 1, 1993; pages 1953-1955; IEEE Service Center, New York, NY.	<input type="checkbox"/>

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